

- ★ Green Device Available
- ★ Super Low Gate Charge
- ★ Excellent Cdv/dt effect decline
- ★ Advanced high cell density Trench technology

### Product Summary

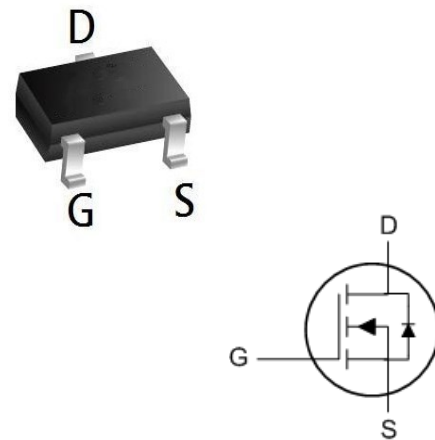
| BVDSS | RDS(on) | ID   |
|-------|---------|------|
| 60V   | 62 mΩ   | 3.5A |

### Description

The XCH6003 is the high cell density trench N-ch MOSFETs, which provides excellent RDS(on) and efficiency for most of the small powers switching and load switch applications.

The XCH6003 meet the RoHS and Green Product requirement with full function reliability approved

### SOT23-3L Pin Configuration



### ■ Absolute Maximum Ratings (T<sub>A</sub>=25°C unless otherwise noted)

| Parameter                              |                       | Symbol                            | Limit    | Unit |
|----------------------------------------|-----------------------|-----------------------------------|----------|------|
| Drain-source Voltage                   |                       | V <sub>DS</sub>                   | 60       | V    |
| Gate-source Voltage                    |                       | V <sub>GS</sub>                   | ±20      | V    |
| Drain Current                          | T <sub>A</sub> =25°C  | I <sub>D</sub>                    | 3.5      | A    |
|                                        | T <sub>A</sub> =100°C |                                   | 1.9      |      |
| Pulsed Drain Current <sup>A</sup>      |                       | I <sub>DM</sub>                   | 18       | A    |
| Total Power Dissipation <sup>B</sup>   | T <sub>A</sub> =25°C  | P <sub>D</sub>                    | 1.2      | W    |
|                                        | T <sub>A</sub> =100°C |                                   | 0.45     |      |
| Junction and Storage Temperature Range |                       | T <sub>J</sub> , T <sub>STG</sub> | -55~+150 | °C   |

### ■ Thermal resistance

| Parameter                                           |              | Symbol           | Typ | Max | Units |
|-----------------------------------------------------|--------------|------------------|-----|-----|-------|
| Thermal Resistance Junction-to-Ambient <sup>C</sup> | Steady-State | R <sub>θJA</sub> | 85  | 105 | °C/W  |

**■ Electrical Characteristics** ( $T_J=25^{\circ}\text{C}$  unless otherwise noted)

| Parameter                             | Symbol              | Conditions                                                                              | Min | Typ  | Max  | Units |
|---------------------------------------|---------------------|-----------------------------------------------------------------------------------------|-----|------|------|-------|
| Static Parameter                      |                     |                                                                                         |     |      |      |       |
| Drain-Source Breakdown Voltage        | BV <sub>DSS</sub>   | V <sub>GS</sub> = 0V, I <sub>D</sub> =250μA                                             | 60  | -    | -    | V     |
| Zero Gate Voltage Drain Current       | I <sub>DSS</sub>    | V <sub>DS</sub> =60V, V <sub>GS</sub> =0V                                               | -   | -    | 1    | μA    |
|                                       |                     | V <sub>DS</sub> =60V, V <sub>GS</sub> =0V, T <sub>j</sub> =150°C                        | -   | -    | 100  |       |
| Gate-Body Leakage Current             | I <sub>GSS</sub>    | V <sub>GS</sub> = ±20V, V <sub>DS</sub> =0V                                             | -   | -    | ±100 | nA    |
| Gate Threshold Voltage                | V <sub>GS(th)</sub> | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA                               | 0.9 | 1.35 | 2    | V     |
| Static Drain-Source On-Resistance     | R <sub>DS(on)</sub> | V <sub>GS</sub> =10V, I <sub>D</sub> =3A                                                | -   | 62   | 85   | mΩ    |
|                                       |                     | V <sub>GS</sub> =4.5V, I <sub>D</sub> =3A                                               | -   | 70   | 95   |       |
| Diode Forward Voltage                 | V <sub>SD</sub>     | I <sub>S</sub> =3A, V <sub>GS</sub> =0V                                                 | -   | 0.85 | 1.2  | V     |
| Gate resistance                       | R <sub>G</sub>      | f=1MHz, Open drain                                                                      | -   | 2    | -    | Ω     |
| Maximum Body-Diode Continuous Current | I <sub>S</sub>      |                                                                                         | -   | -    | 3    | A     |
| Dynamic Parameters                    |                     |                                                                                         |     |      |      |       |
| Input Capacitance                     | C <sub>iss</sub>    | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, f=1MHz                                       | -   | 500  | -    | pF    |
| Output Capacitance                    | C <sub>oss</sub>    |                                                                                         | -   | 28   | -    |       |
| Reverse Transfer Capacitance          | C <sub>rss</sub>    |                                                                                         | -   | 22   | -    |       |
| Switching Parameters                  |                     |                                                                                         |     |      |      |       |
| Total Gate Charge                     | Q <sub>g</sub>      | V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =3A                          | -   | 10   | -    | nC    |
| Gate-Source Charge                    | Q <sub>gs</sub>     |                                                                                         | -   | 1.7  | -    |       |
| Gate-Drain Charge                     | Q <sub>gd</sub>     |                                                                                         | -   | 2.1  | -    |       |
| Reverse Recovery Charge               | Q <sub>rr</sub>     | I <sub>F</sub> =3A, di/dt=100A/us                                                       | -   | 7    | -    | nC    |
| Reverse Recovery Time                 | t <sub>rr</sub>     |                                                                                         | -   | 33   | -    | ns    |
| Turn-on Delay Time                    | t <sub>D(on)</sub>  | V <sub>GS</sub> =10V, V <sub>DD</sub> =30V, R <sub>L</sub> =20Ω<br>R <sub>GEN</sub> =3Ω | -   | 3.6  | -    | ns    |
| Turn-on Rise Time                     | t <sub>r</sub>      |                                                                                         | -   | 17.6 | -    |       |
| Turn-off Delay Time                   | t <sub>D(off)</sub> |                                                                                         | -   | 13   | -    |       |
| Turn-off fall Time                    | t <sub>f</sub>      |                                                                                         | -   | 23   | -    |       |

A. Repetitive rating; pulse width limited by max. junction temperature.

B.  $P_d$  is based on max. junction temperature, using junction-case thermal resistance.

C. The value of  $R_{\theta JA}$  is measured with the device mounted on the minimum recommend pad size, in the still air environment with  $T_A=25^{\circ}\text{C}$ . The maximum allowed junction temperature of  $150^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design.

■ Typical Electrical and Thermal Characteristics Diagrams

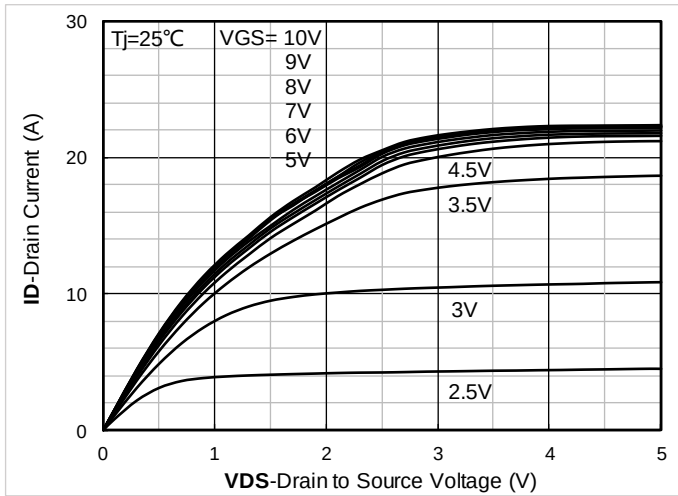


Figure 1. Output Characteristics

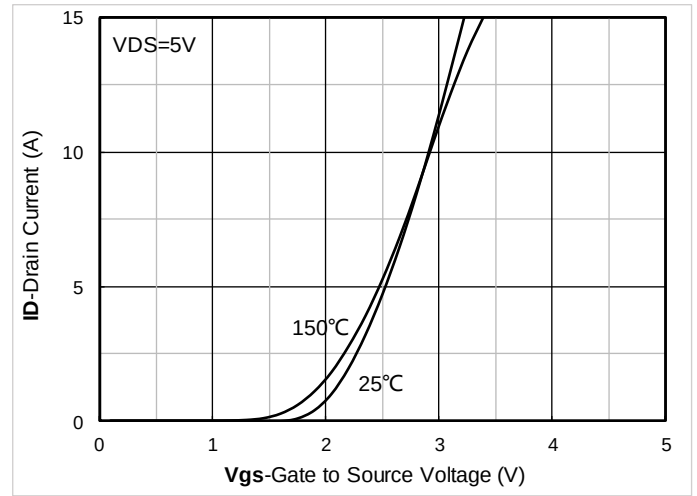


Figure 2. Transfer Characteristics

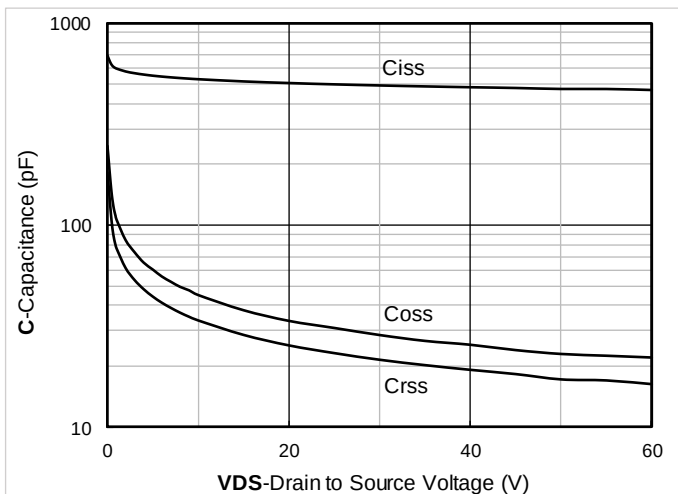


Figure 3. Capacitance Characteristics

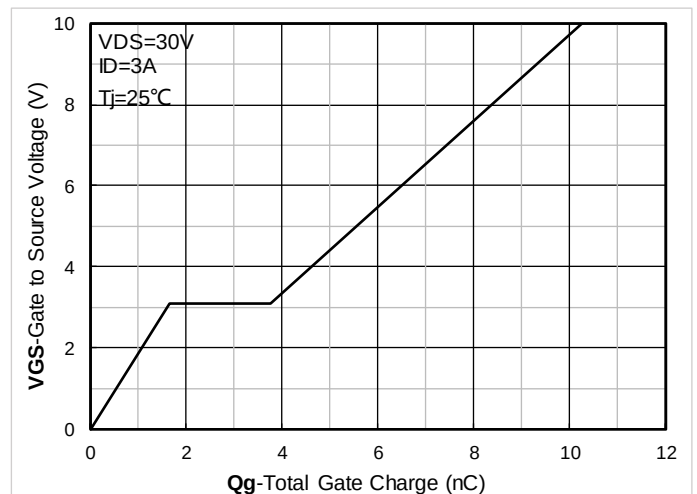


Figure 4. Gate Charge

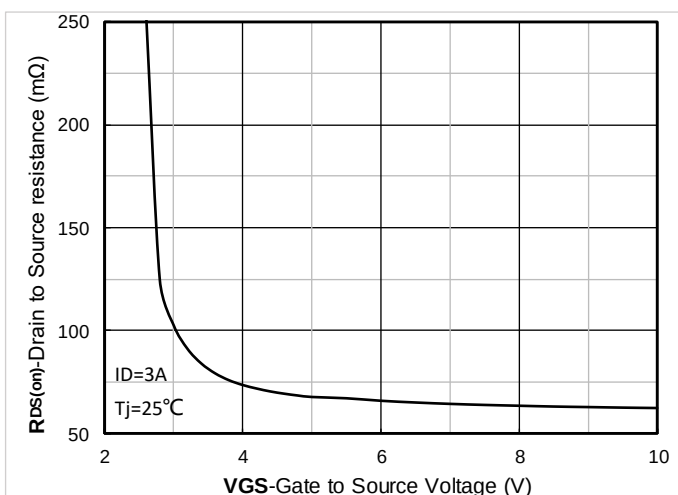


Figure 5. On-Resistance vs Gate to Source Voltage

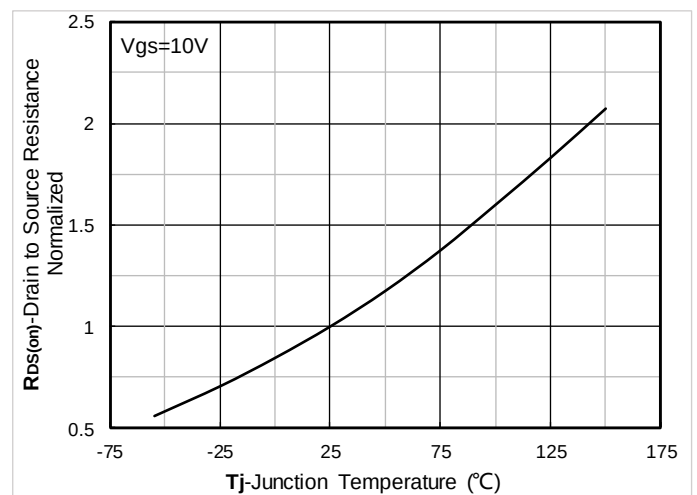


Figure 6. Normalized On-Resistance

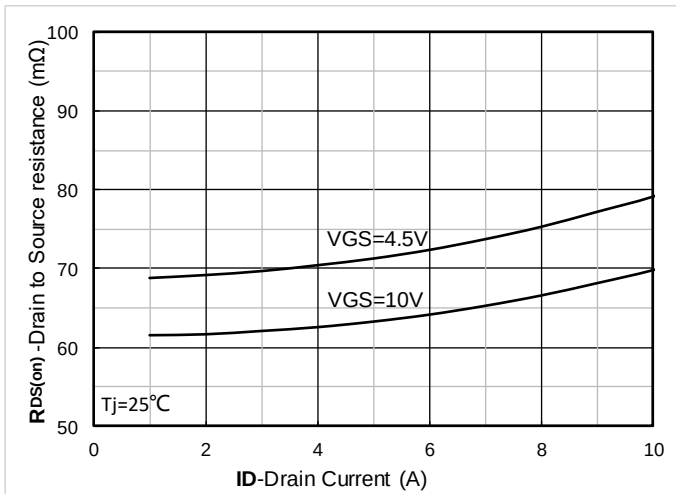


Figure 7.  $R_{DS(on)}$  VS Drain Current

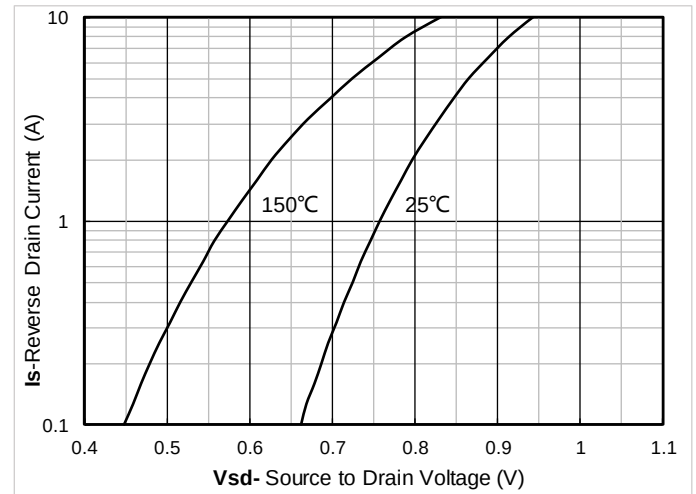


Figure 8. Forward characteristics of reverse diode

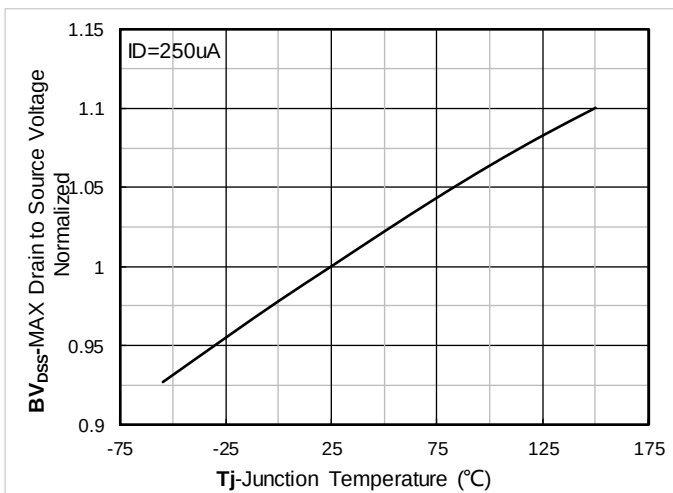


Figure 9. Normalized breakdown voltage

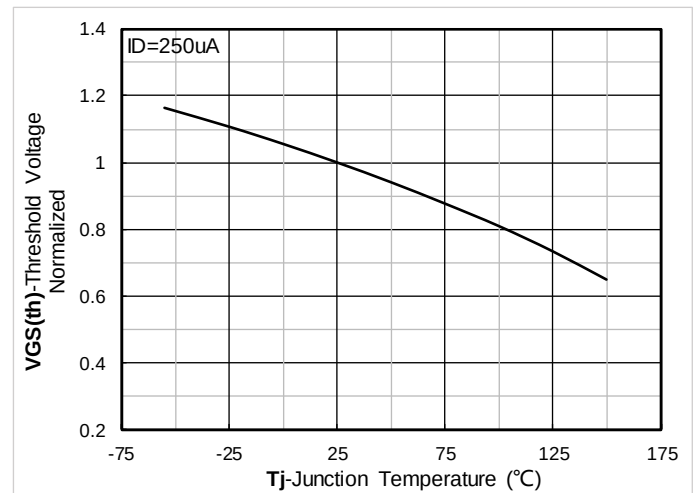


Figure 10. Normalized Threshold voltage

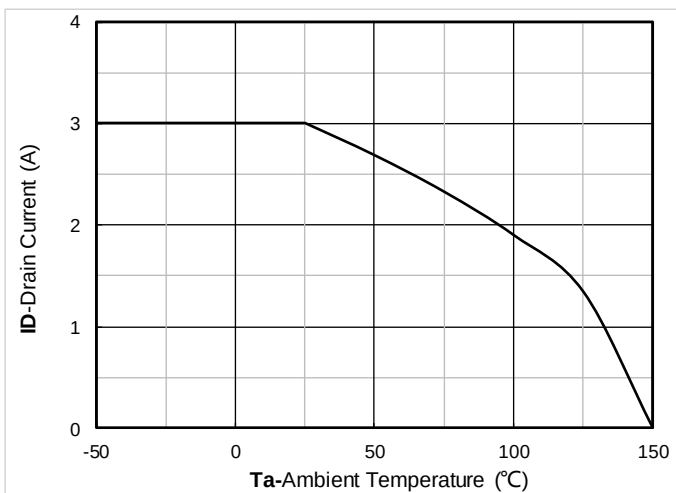


Figure 11. Current dissipation

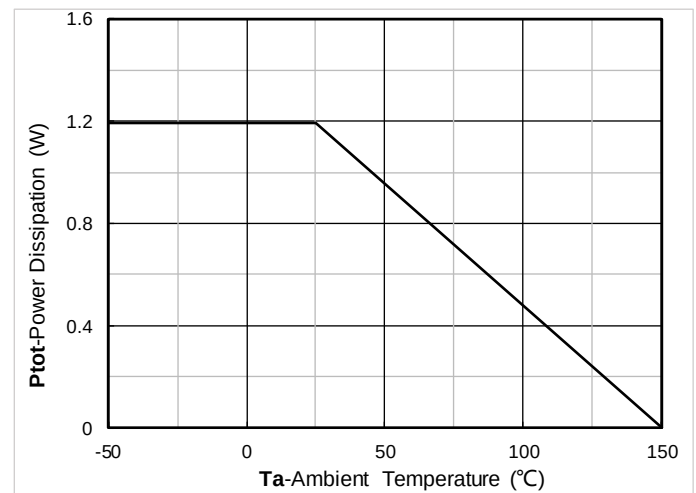


Figure 12. Power dissipation

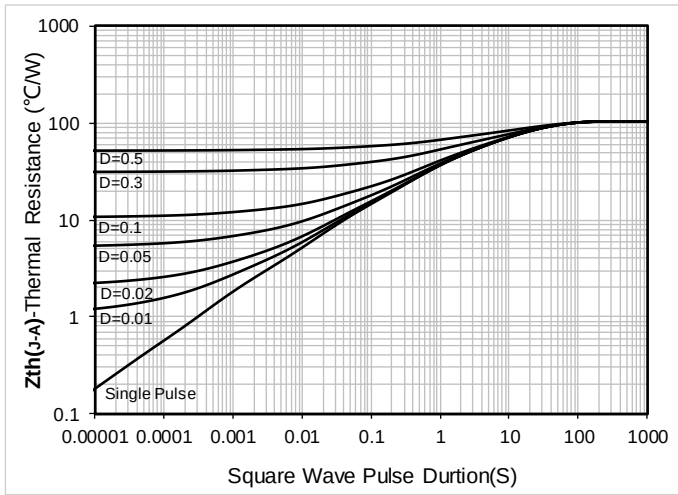


Figure 13. Maximum Transient Thermal Impedance

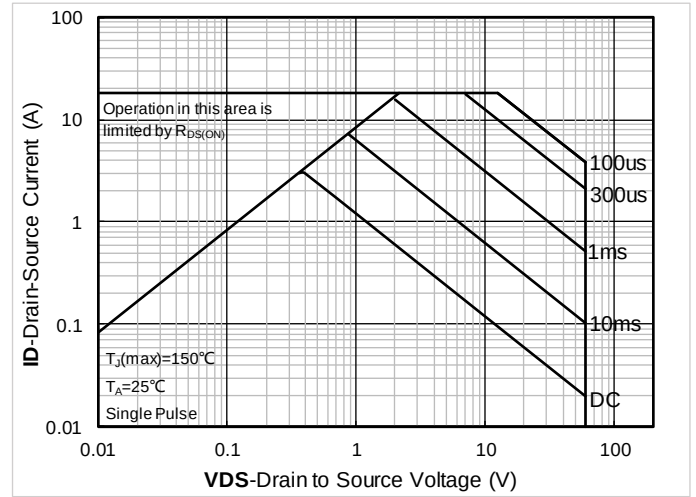


Figure 14. Safe Operation Area

## ■ Test Circuits & Waveforms

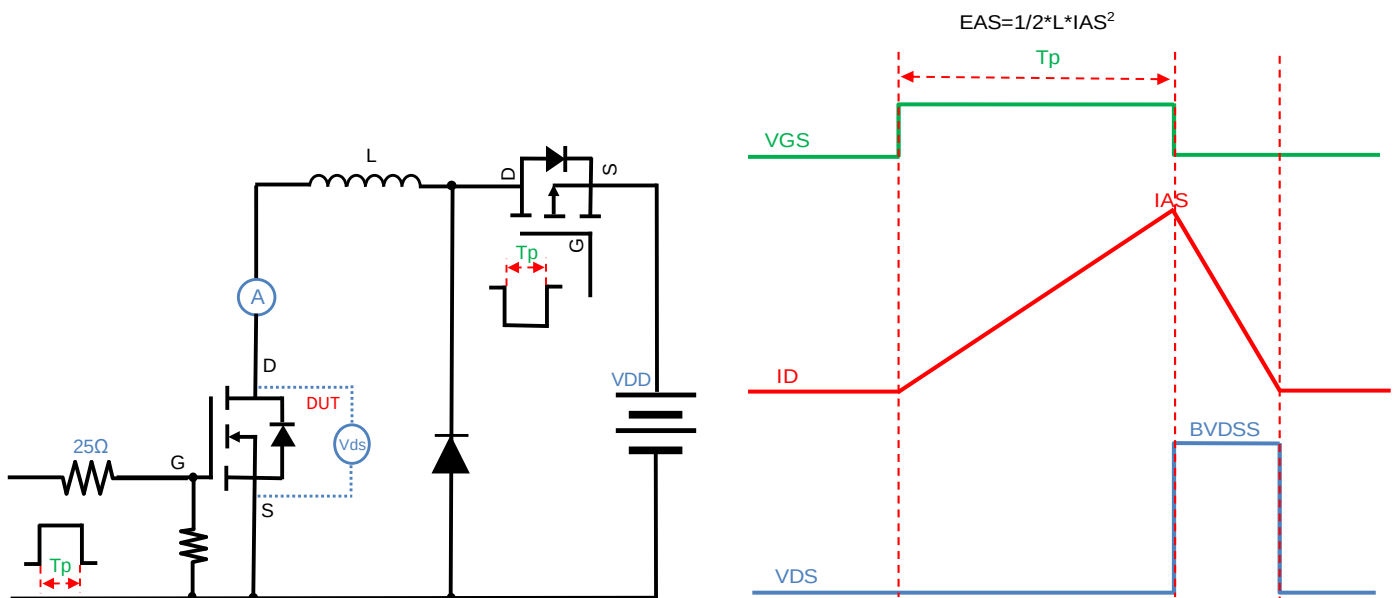


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform

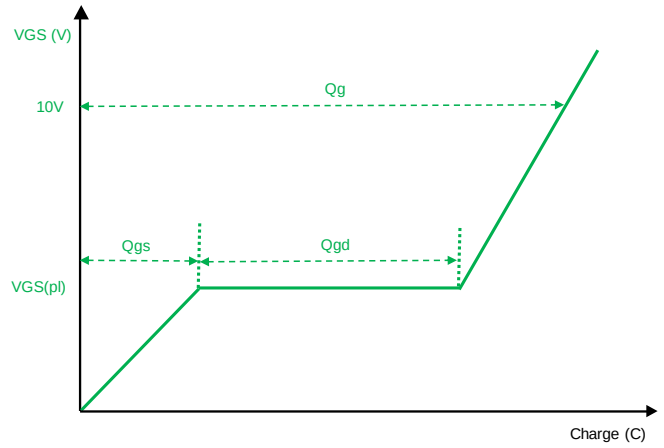
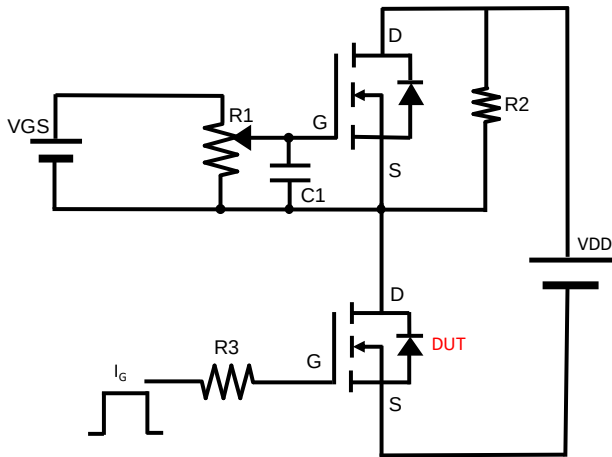


Figure B. Gate Charge Test Circuit & Waveform

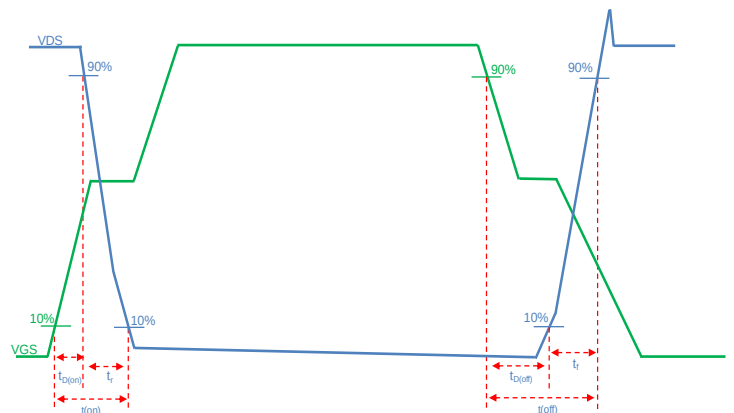
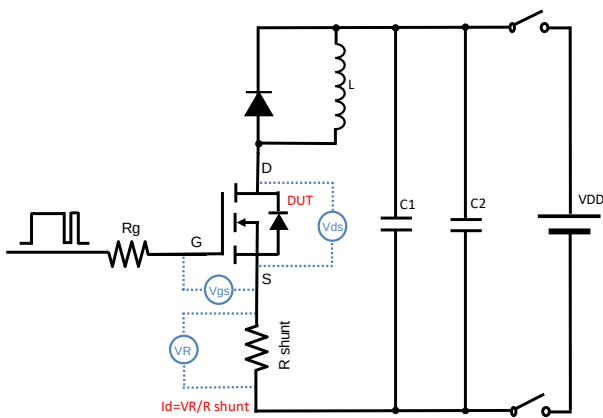


Figure C. Resistive Switching Test Circuit & Waveform

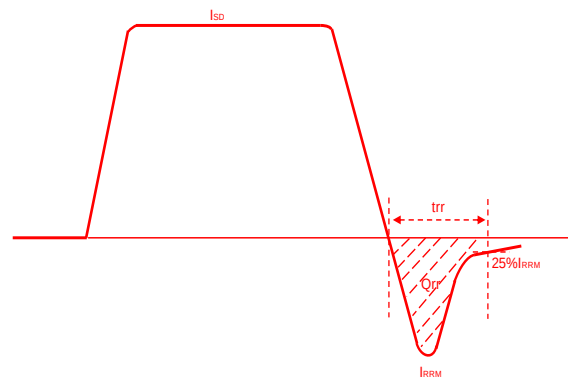
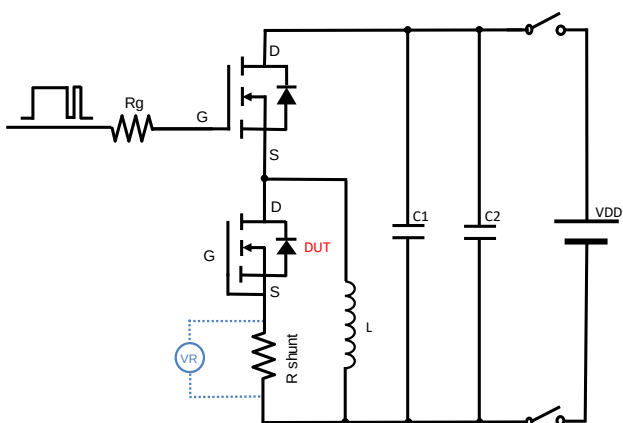


Figure D. Diode Recovery Test Circuit & Waveform